

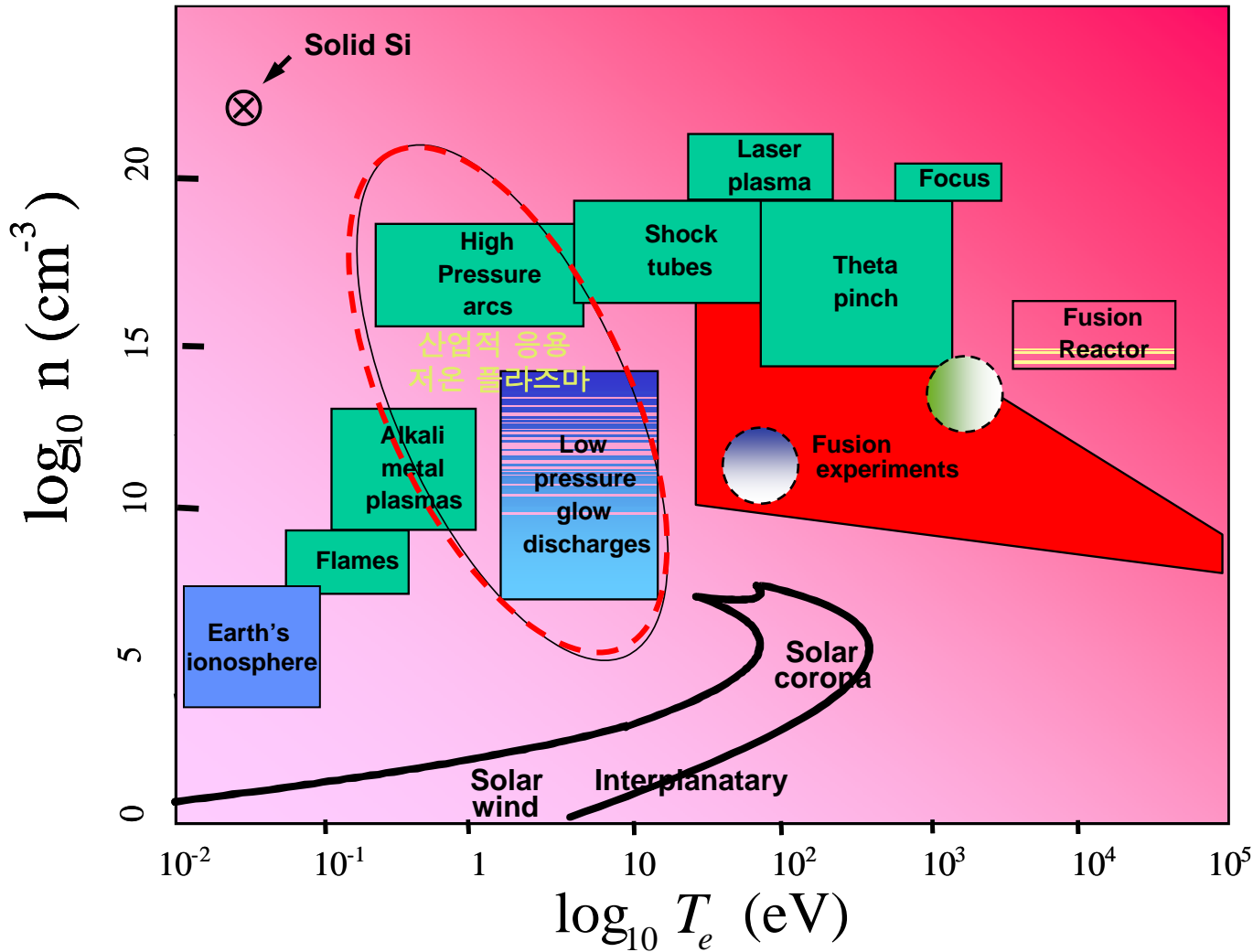
금속-폴리머 접착력 증진을 위한 플라즈마 표면처리

KIST

Advanced Metals Research Center

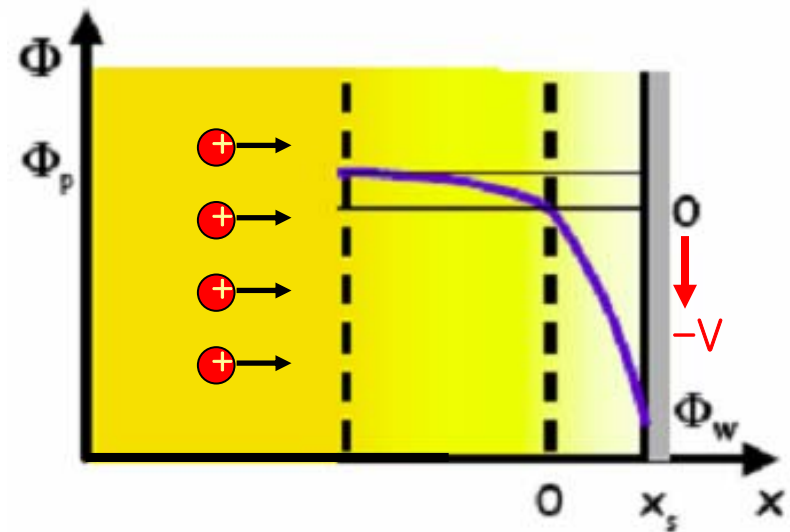
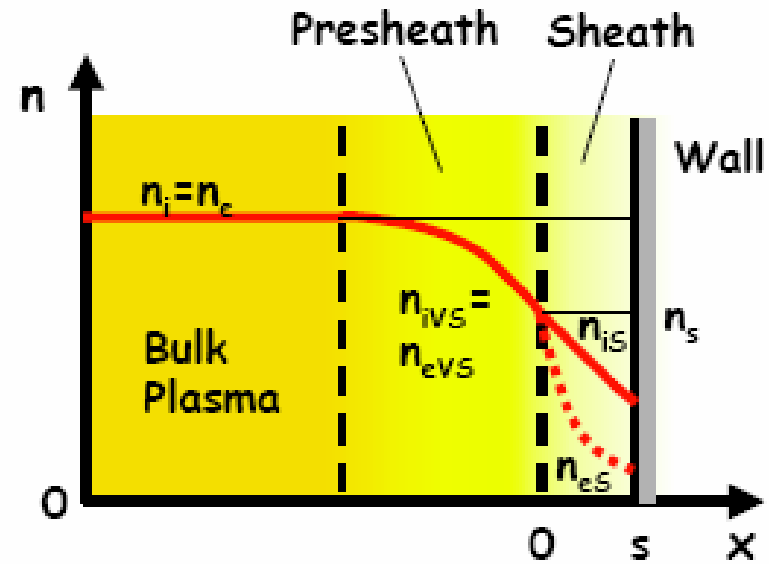
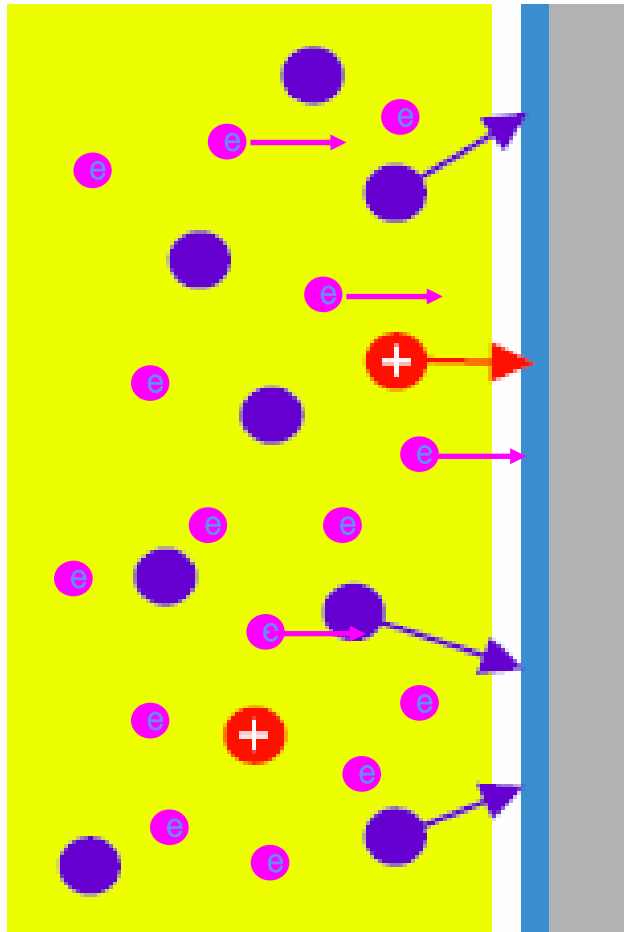
Seunghee Han

Plasma Properties



- ◆ 1 eV = 10,000 K
- ◆ $T_i, T_n \ll T_e$
- ◆ $\eta < 1\%$
- ◆ Radical species

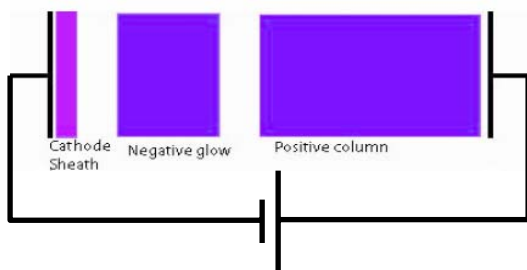
Plasma Sheath



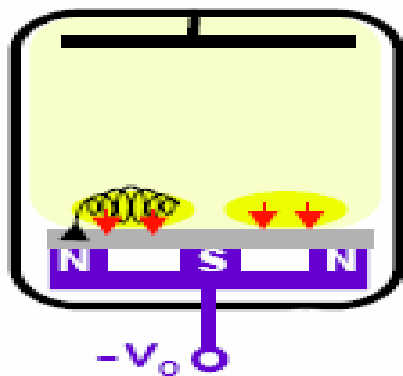
Plasma Generation

DC

DC

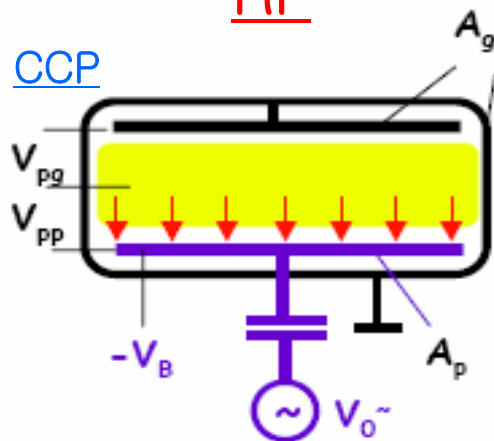


DC-Magnetron

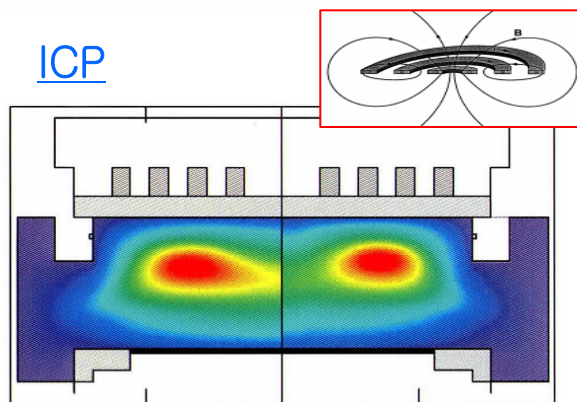


RF

CCP

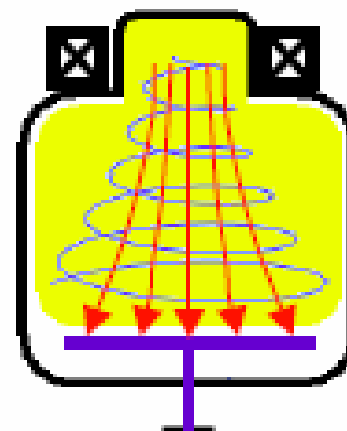


ICP



MW

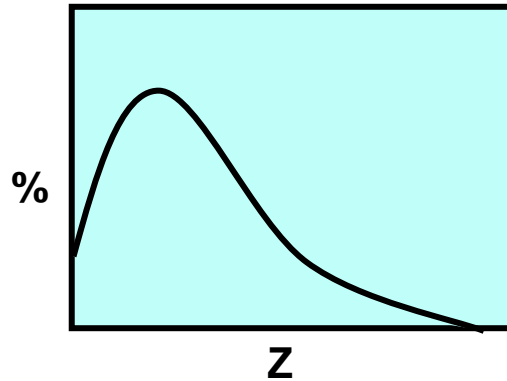
ECR



- ◆ Helicon, SW, Laser, Arc, etc

Ion Implantation

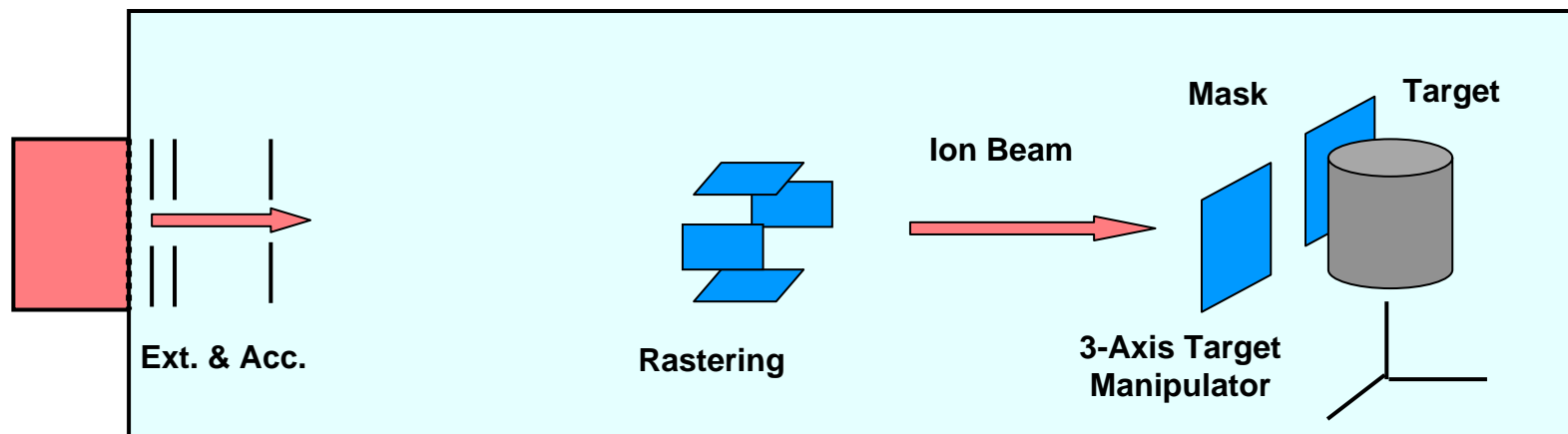
- Injection of high energy ions into materials surface



Advantages of ion implantation

- Selective improvement of surface region
- No sharp interface
- No dimensional change or distortion
- High-energy / non-equilibrium process
- Easy process control

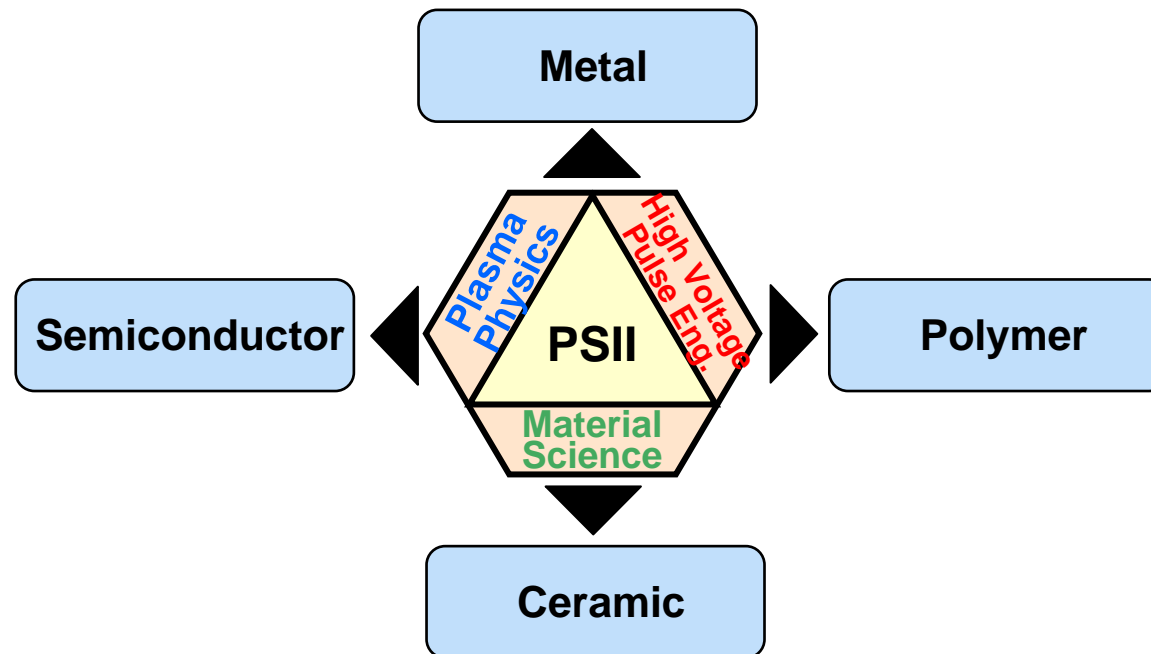
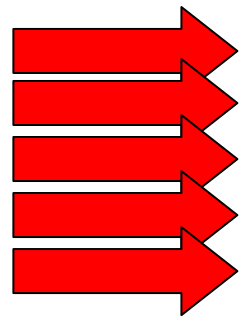
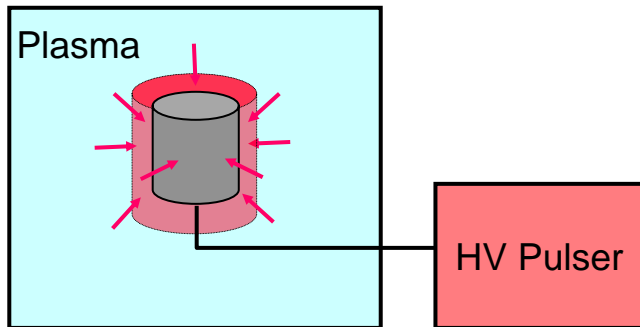
Ion-beam ion implantation



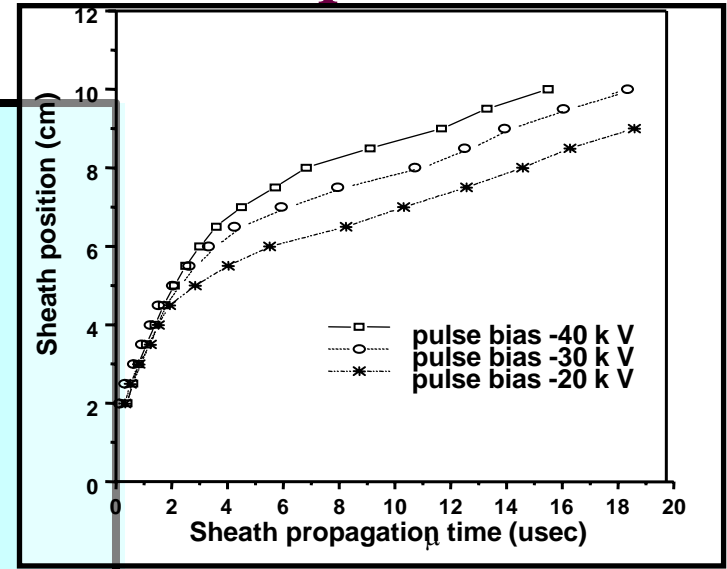
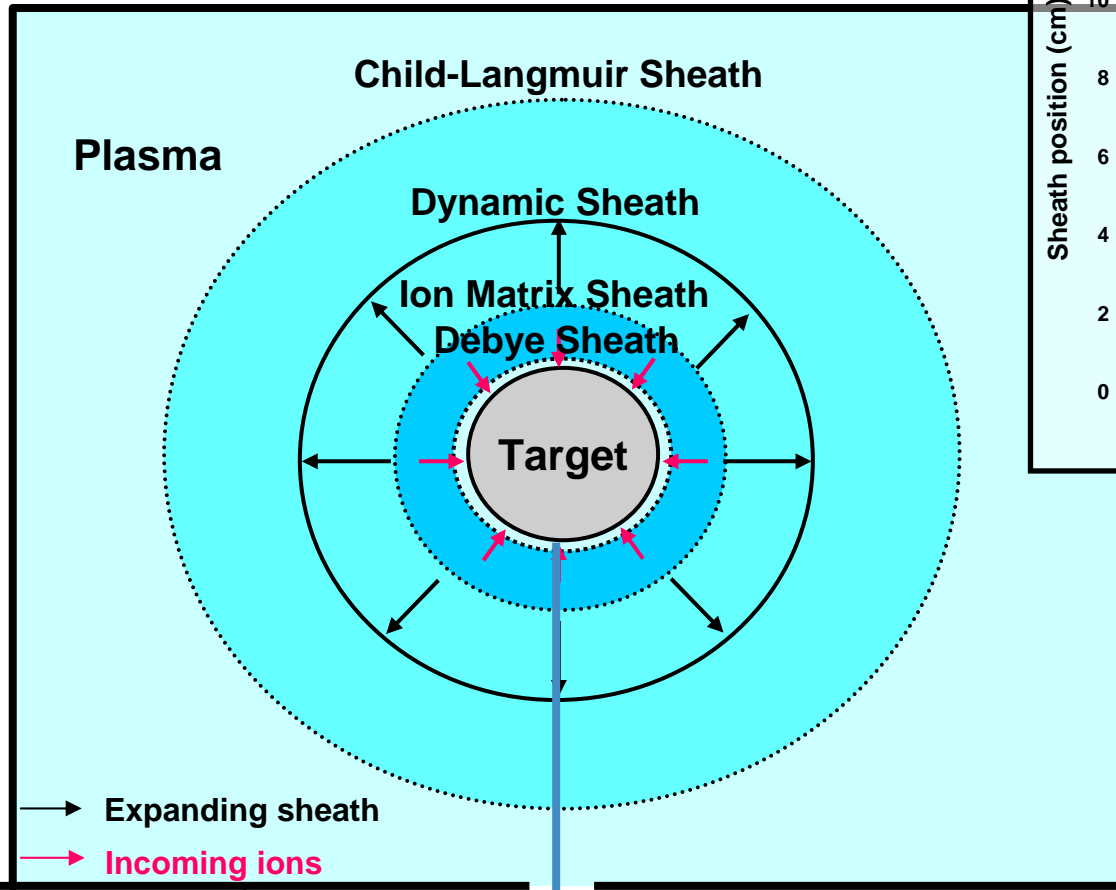
Plasma Source Ion Implantation (PSII, PIII)

Advantages of PSII

- Uniform implantation over 3-D & large target
- Simple and economic
- High dose rate
- Implantation capability on insulators
- Modular design



Plasma Source Ion Implantation - Principle



PSII Modes

CW Plasma + HV pulse
 or
Pulsed Plasma + DC bias
 or
Pulsed Plasma + HV pulse



Vacuum chamber wall



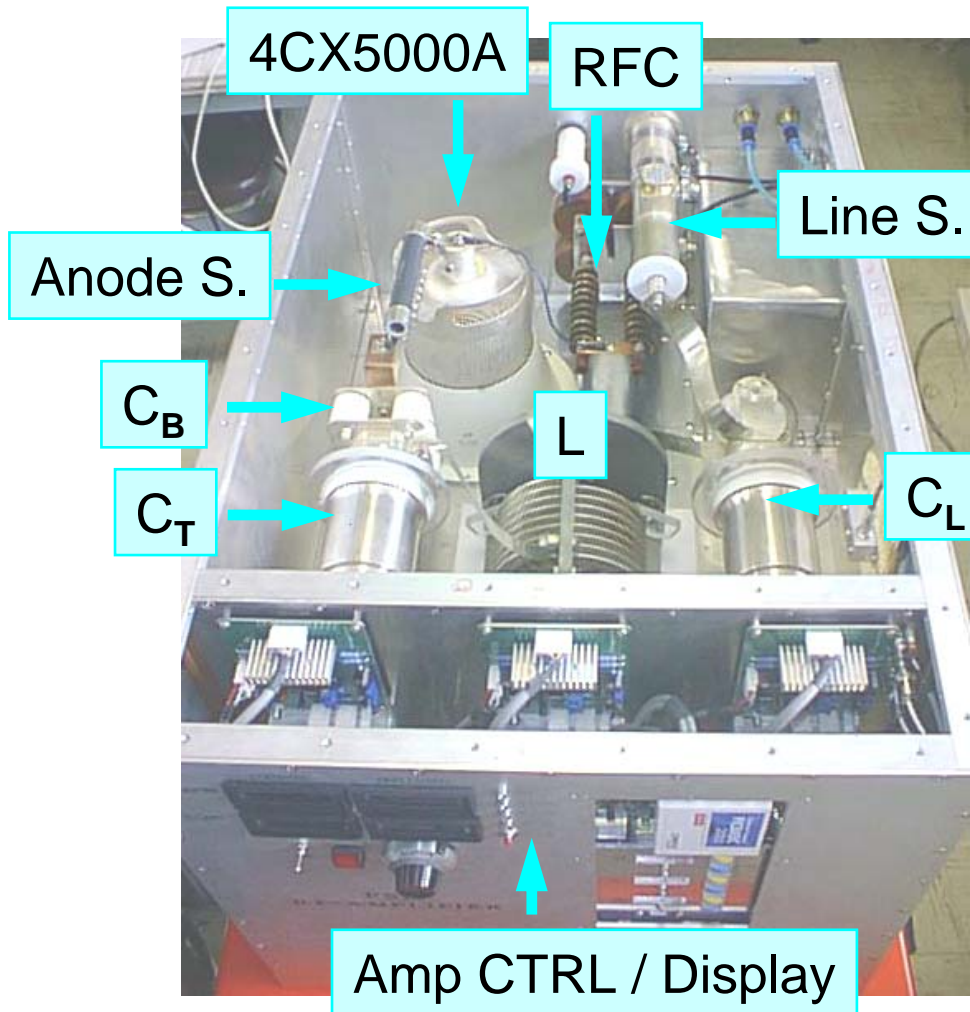
HV Pulser

Advantages of Pulsed Plasma

Pulsed plasma has been widely used in many processes because it has several advantages over continuous (CW) plasma.

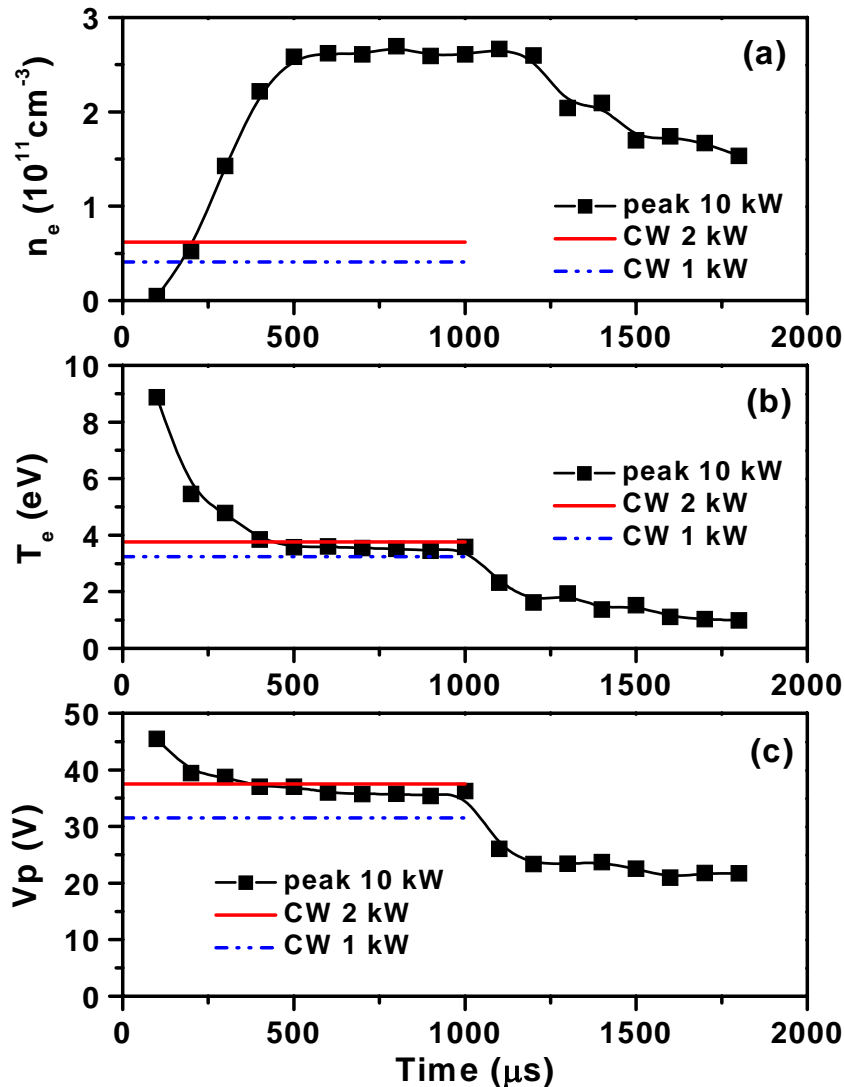
- Ion species can be varied.
- Discharge chemistry is changed.
- Charging damage is low.
- Film quality is improved in deposition.
- Etch and deposition rate increase.
- Very well suited for pulsed-process nature of PSII.

Amplifier RF-Deck



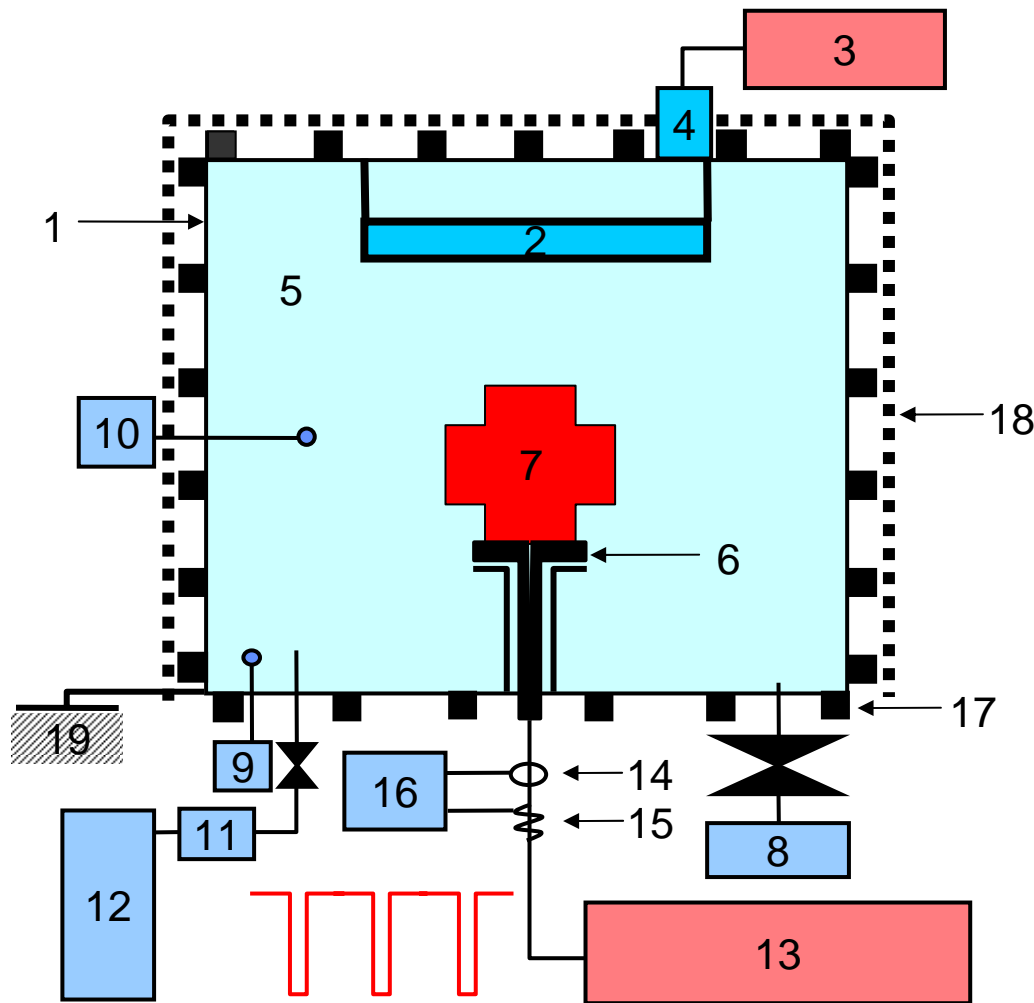
- 13.56 MHz, 50 kW peak, 3 kW avg.
- 4CX5000A RF Tetrode
- Pi-tank matching network to 50 Ω (2 vacuum caps / roller inductor)
- L-R anode parasitic suppression
- Forward / reflected RF power monitored using 1-5/8" rigid LS and Bird RF elements
- Microprocessor-controlled power measurement and SWR protection
- Easy and safe tuning with stepper Motors

Time-resolved Plasma Parameters



- Peak RF power : 10 kW, RF pulse width : 1 ms, pulse repetition frequency : 25 Hz
- At early stage, the electron density is low and electron temperature and plasma potential is high.
- During the RF pulse on time, plasma parameters reach the steady state after about 500 μs .
- Plasma parameters are similar to continuous wave (CW) operation from about 500 μs to the end of the RF pulse except the electron density.
- After the RF pulse is turned off, plasma parameters decrease gradually.

Schematic Diagram of PSII Equipment



- | | |
|--------------------|--------------------|
| 1. Vac. chamber | 2. Antenna |
| 3. RF generator | 4. Matching box |
| 5. Plasma | 6. Target stage |
| 7. Target | 8. Vac. Pump |
| 9. Ion gauge | 10. Langmuir probe |
| 11. MFC | 12. Working gas |
| 13. HV pulse gen. | 14. CT |
| 15. HV divider | 16. Oscilloscope |
| 17. Magnets | 18. Lead shield |
| 19. Chamber ground | |

PSII Equipments

PSII - I (100L, 100kV, 10A)

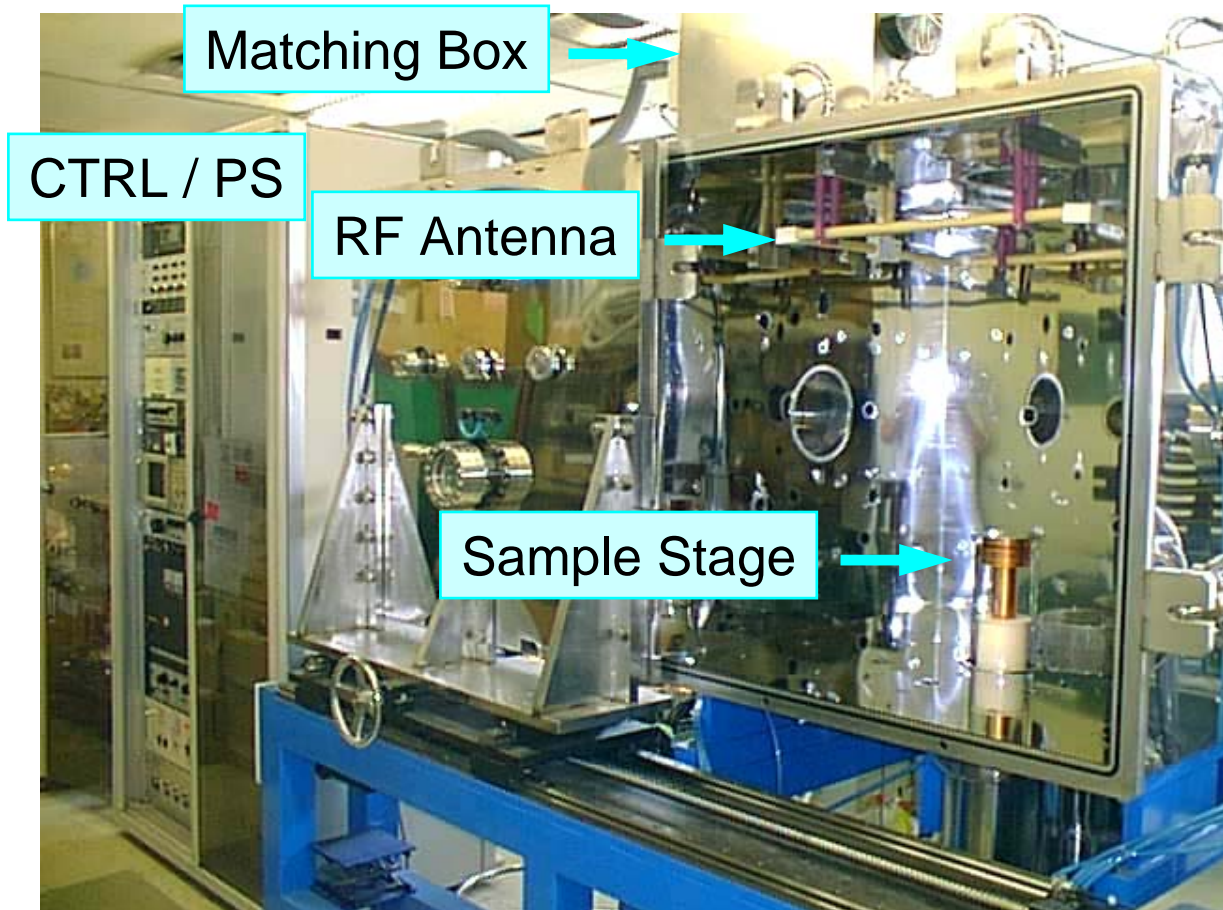


PSII - II (60L, 10kV, 2A)



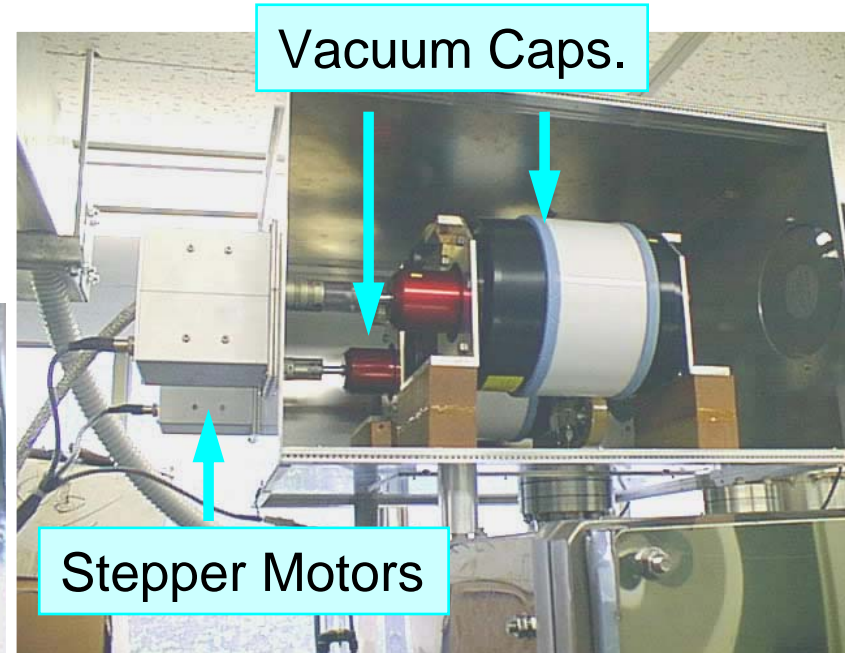
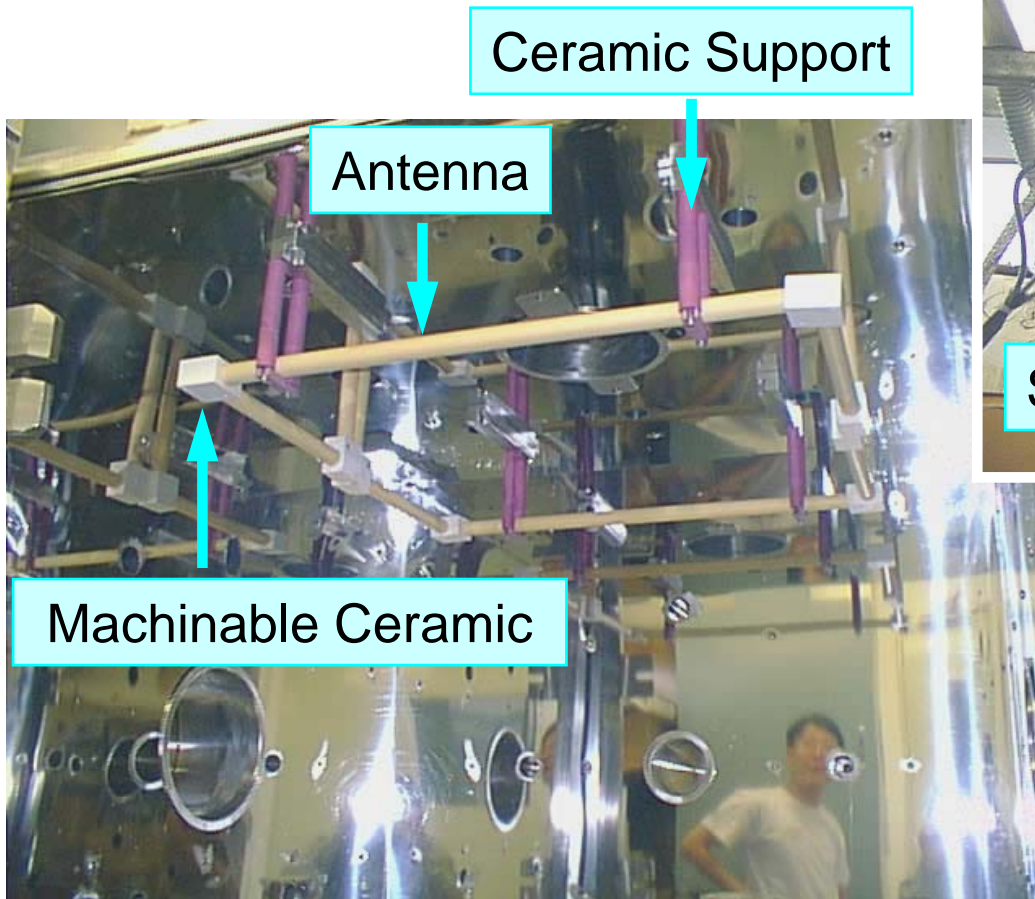
New PSII Facility for Large Sample Implantation

PSII - III (1000L, 100kV, 30A)



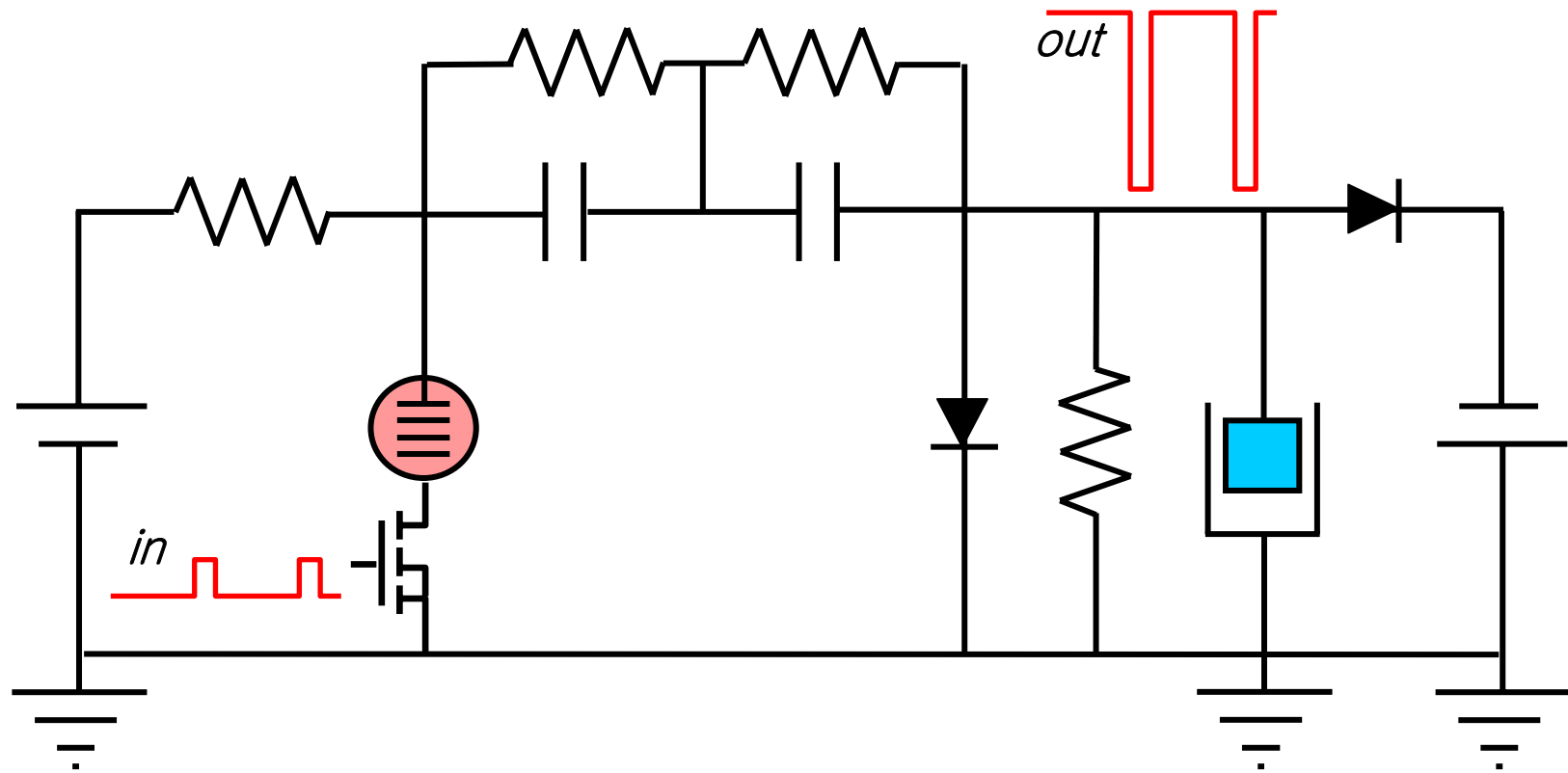
- 1m x 1m x 1m
- Nd-Fe-B magnet cusps
- Water-cooled walls
- 2000 L/s turbo-pumped
- Lead-shielded (6 mm T)
- Sliding-door type
- Ceramic-insulated, internal antenna (water-cooled)
- Protected by inner-liners
- Oil-cooled sample stage
- Oil-insulated HVFT

RF Antenna / Matching Box

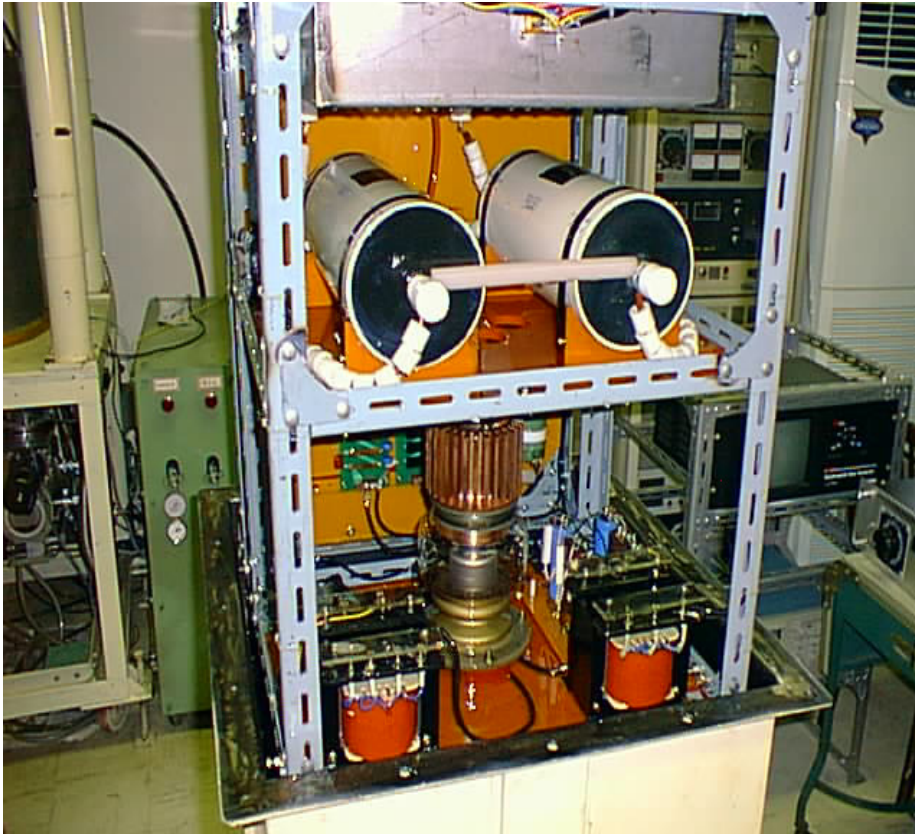


- Standard-type matching network
- Two vacuum capacitors and one ceramic capacitor
- Stepper-motor driven from remote controller

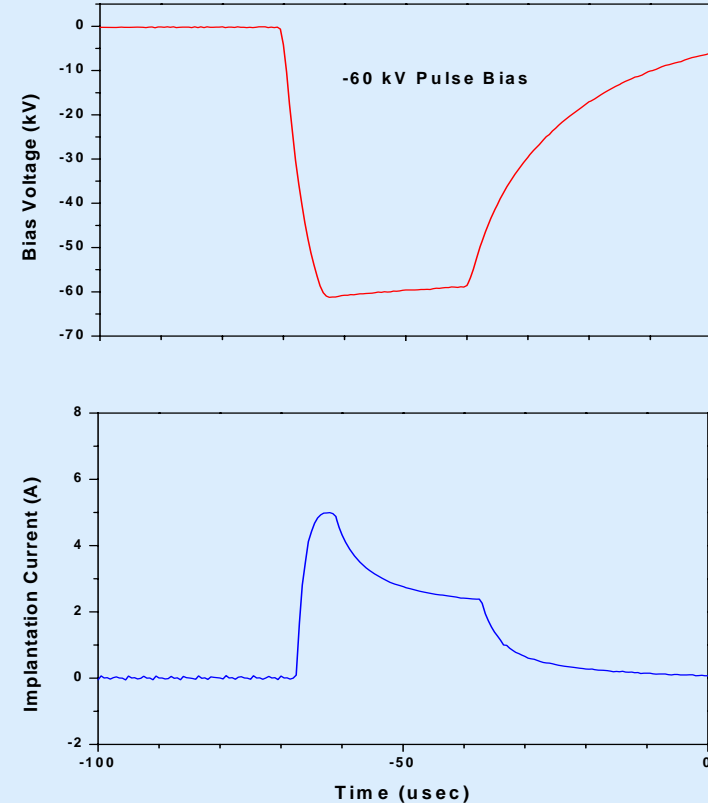
Circuit Diagram of HV Pulse Generator



Internal View of HV Pulse Modulator

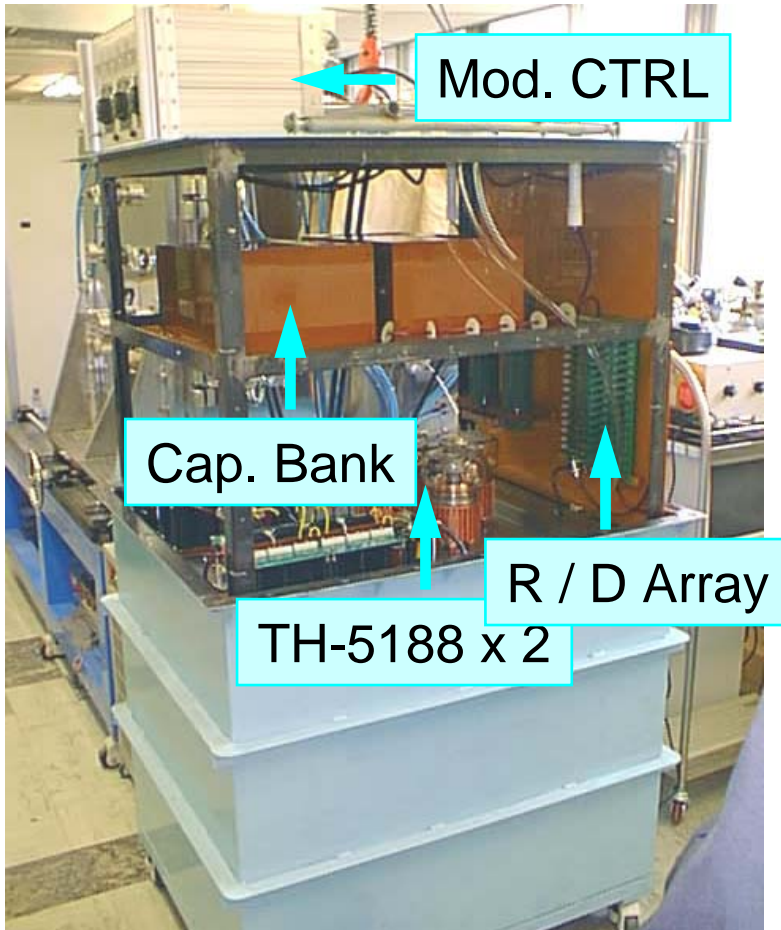


Implantation voltage and current



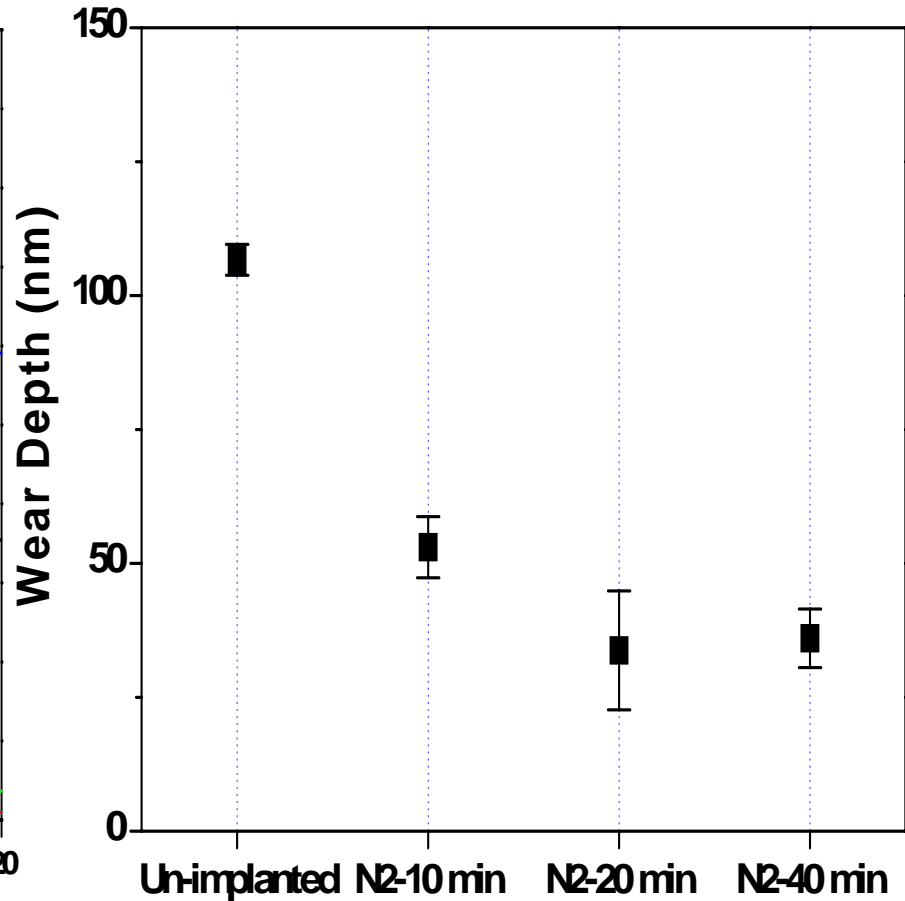
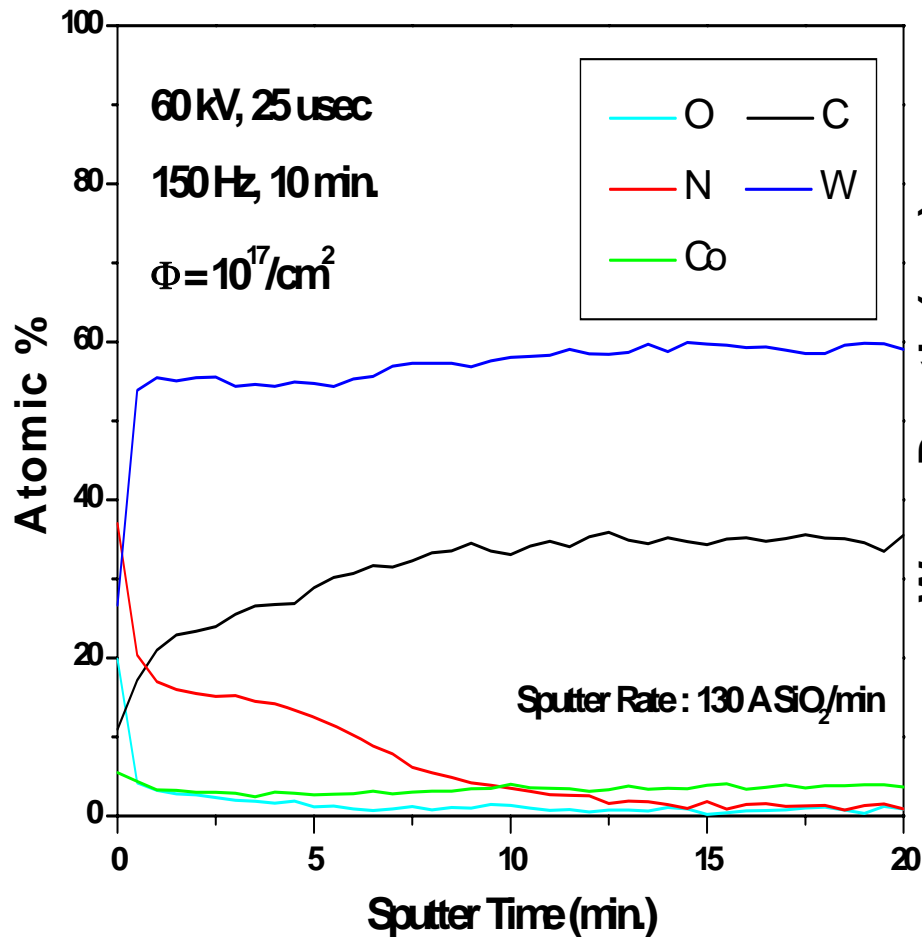
- Dual-mode hard tube type high voltage pulse generator.
- Using high voltage tetrode (TH-5188) and capacitor bank.
- 100 kV, 10 A, 10~60 μ sec, 10~10000 Hz.

High Voltage Pulse Modulator



- Hard-tube type using CB and TH-5188's
- 2 x TH5188 - MOSFET cascode circuit
- 100 kV, 30 A HV pulse
- DC-mode possible for sputter cleaning
- RC Voltage divider for V_i monitoring (10000 : 1)
- Immersed in oil tank
- Will be upgraded using IGBT stack

PSII N₂-implantation on Co-cemented WC



PSII N₂-implantation on Cr-plated SKD61

20 um Hard-Cr plating on polished SKD61



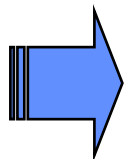
N ion implantation
(N₂, 60 kV, 25 usec, 30 min.)



Pin-on-disc wear tester
(100 g, 200 rpm, 10000 rev. 3 mm-Dia. Ruby ball)

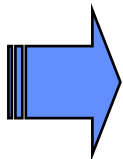
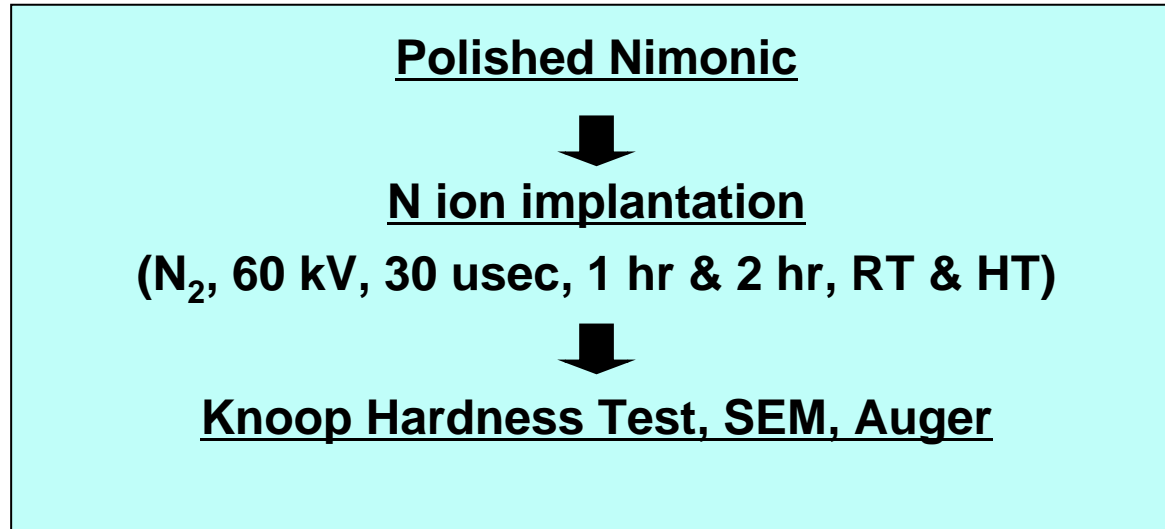


α-step Measurement of wear-track



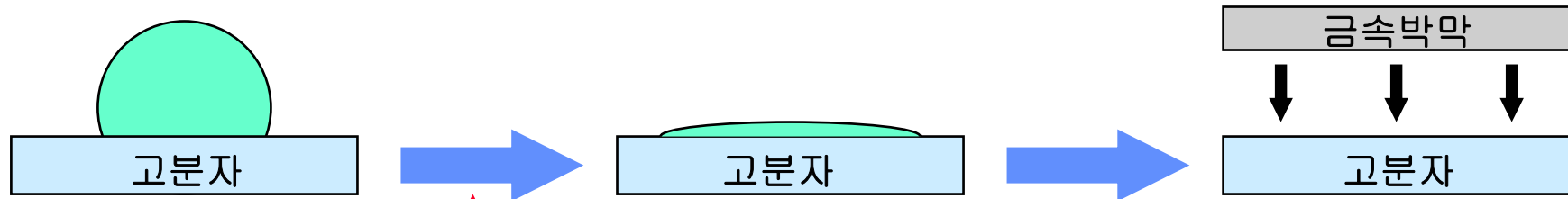
Un-implanted	1 mTorr 200 W RF 100 Hz	1 mTorr 200 W RF 200 Hz	0.5 mTorr 100 W RF 200 Hz	0.5 mTorr 100 W RF 100 Hz
1059 nm	56 nm	101 nm	106 nm	56 nm

PSII N₂-implantation on Nimonic (Cr-Ni, Al, Ti....)



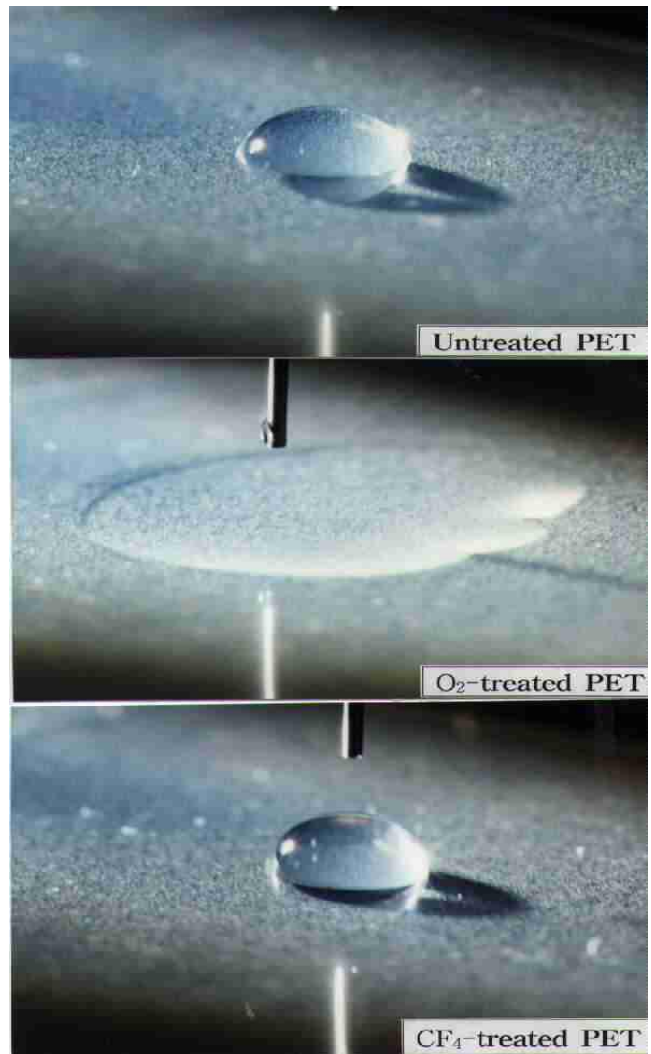
Un-implanted	RT 1 hr.	RT 2 hr.	HT 1 hr.	HT 2 hr.
350 HK	396 HK	405 HK	1129 HK	1246 HK

Polymer Surface Modification

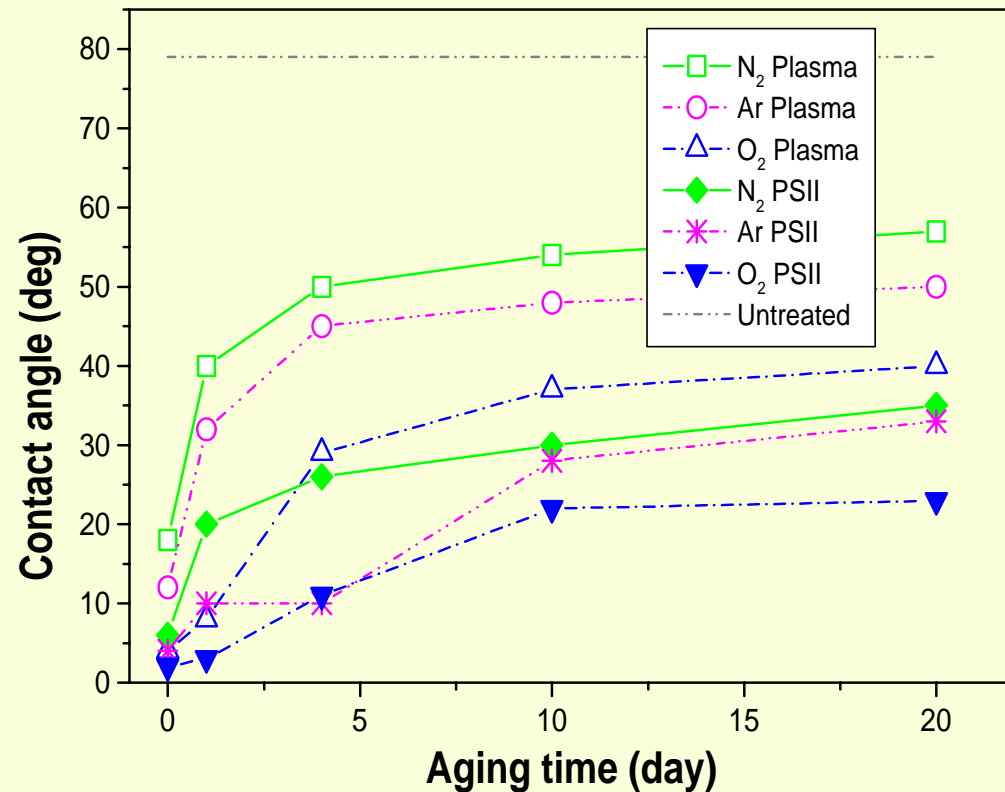


- Chemical
- Flame
- Corona (UV, Laser)
- ⋮
- 플라즈마 (이온빔)
- 중간층 (Tie-layer)

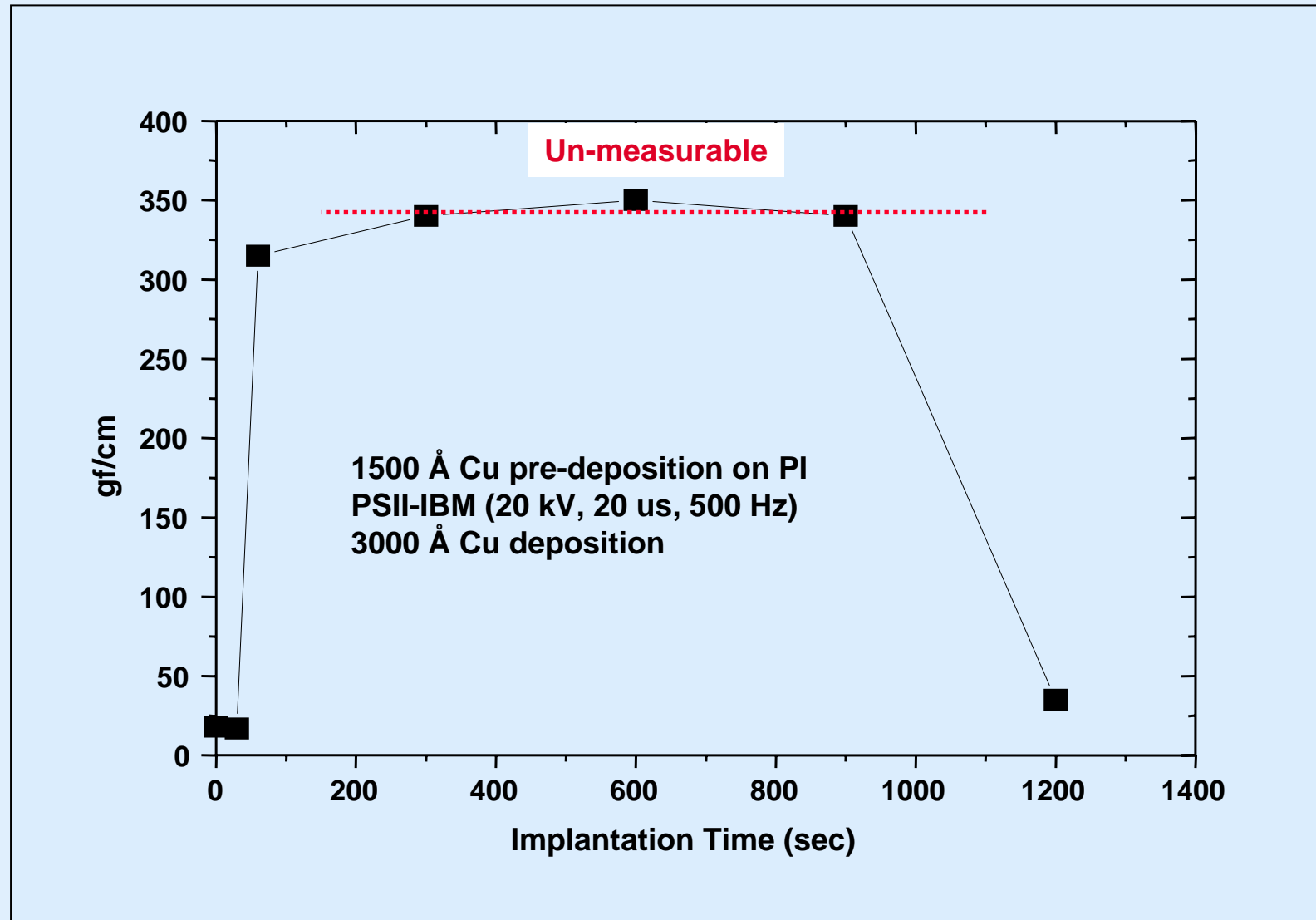
Polymer Surface Modification using PSII



Water contact angles of PS as a function of aging time

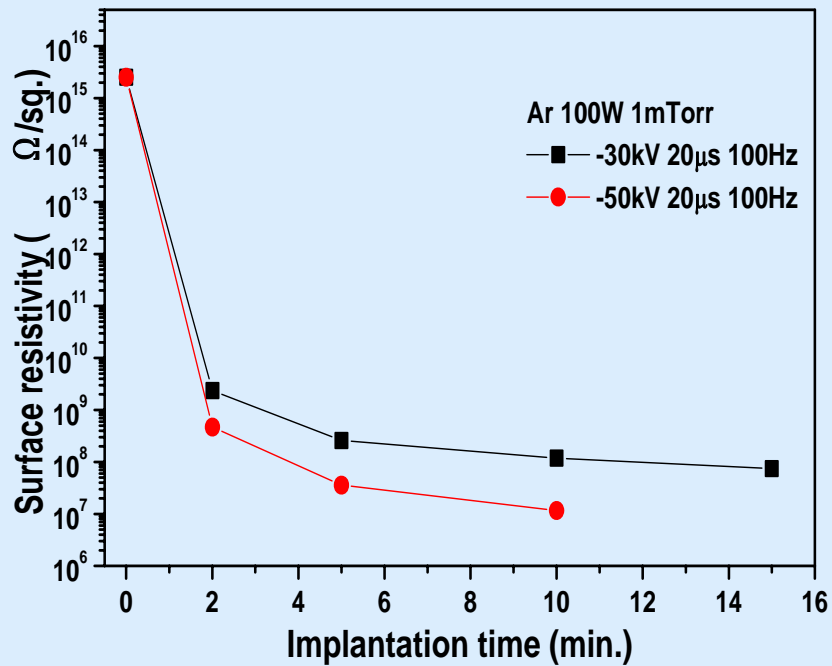


Improvement of Cu-PI adhesion using PSII

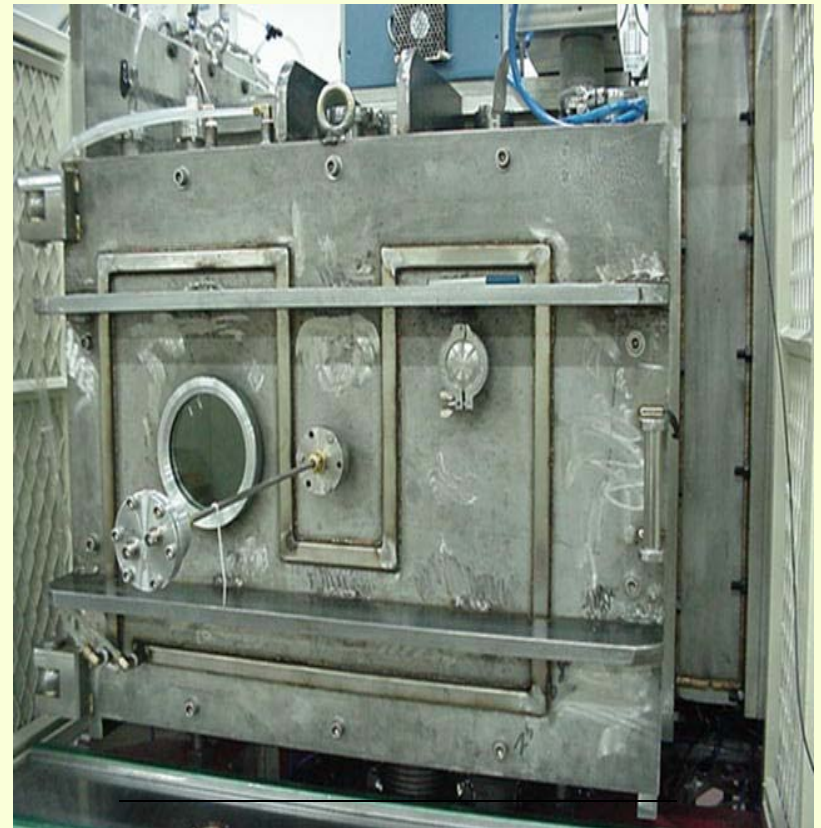


Polymer Surface Modification using PSII

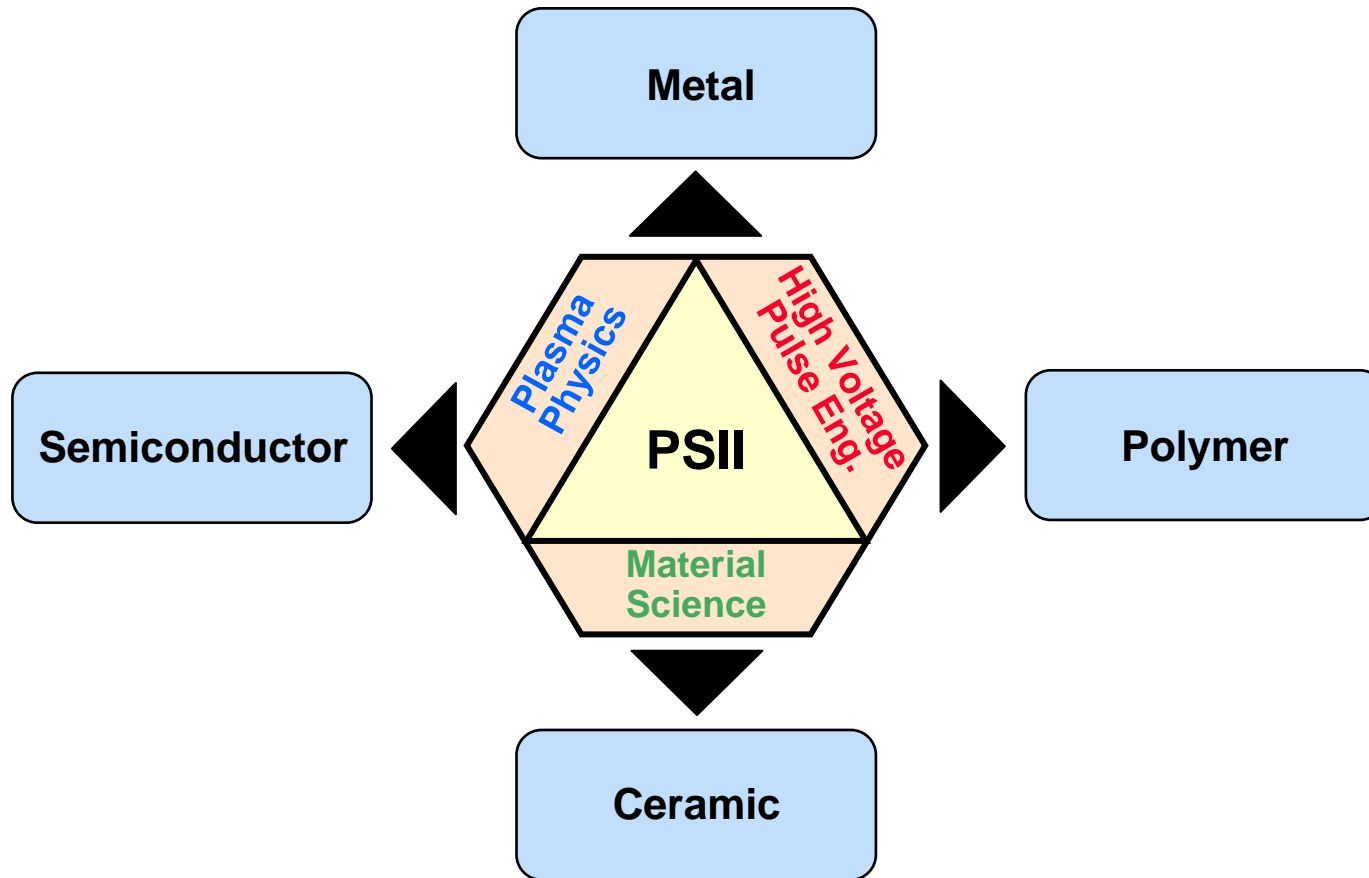
Surface resistivity of MPPO as a function of ion energy



Epon's PSII chamber for IC-tray implantation



Conclusion



Plasma / PSII is a very promising tool for materials surface modification !!